Description

JMT N-channel Enhancement Mode Power MosFET

Features

• 30V, 70A

 $R_{DS(ON)} < 6.0 \text{m}\Omega$ @ $V_{GS} = 10V$ $R_{DS(ON)} < 9.5 \text{m}\Omega$ @ $V_{GS} = 4.5V$

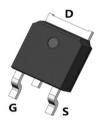
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free

Applications

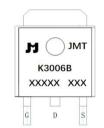
- Load Switch
- PWM Application
- Power Management

100% UIS TESTED! 100% ΔVds TESTED!

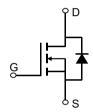












Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Outline	Package	Reel Size	Reel(pcs)	Per Carton (pcs)
JMTK3006B	JMTK3006BN	TAPING	TO-252-3L	13"	2500	25000

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units	
V _{DS}	Drain-to-Source Voltage		30	V	
V_{GS}	Gate-to-Source Voltage		±20	V	
I _D	Continuous Drain Current	T _C = 25°C	70	^	
		T _C = 100°C	45	Α	
I _{DM}	Pulsed Drain Current (1)		280	Α	
E _{AS}	Single Pulsed Avalanche Energy (2)		81	mJ	
P_{D}	Power Dissipation $T_C = 25^{\circ}C$		50	W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾		31	°C/W	
$R_{ heta JC}$	Thermal Resistance, Junction to Case		2.5		
T_{J} , T_{STG}	Junction & Storage Temperature Range		-55 to 150	°C	

Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1.0	μА
I_{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	aracteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0	1.6	2.5	V
		$V_{GS} = 10V, I_D = 30A$	-	4.6	6.0	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 4.5V, I_D = 20A$	-	7.3	9.5	mΩ
Dynam	ic Characteristics					
C _{iss}	Input Capacitance		-	1788	-	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 15V,$	-	225	-	pF
C_{rss}	Reverse Transfer Capacitance	- f = 1MHz	-	180	-	pF
Q_g	Total Gate Charge		-	34	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$	-	6.5	-	nC
Q_{gd}	Gate Drain("Miller") Charge	$V_{DS} = 15V, I_{D} = 30A$	-	7.5	-	nC
Switch	ing Characteristics					
$t_{d(on)}$	Turn-On DelayTime		-	7	-	ns
t _r	Turn-On Rise Time	V _{GS} = 10V, V _{DD} = 15V	-	14	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	$I_D = 30A$, $R_{GEN} = 3\Omega$	-	34	-	ns
t _f	Turn-Off Fall Time		-	11	-	ns
Drain-S	Source Diode Characteristics and M	ax Ratings				
I _s	Maximum Continuous Drain to Source Diode Forward Current			-	70	А
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	280	А
V_{SD}	Drain to Source Diode ForwardVoltage	$V_{GS} = 0V, I_{S} = 30A$	-	-	1.2	V
trr	Body Diode Reverse Recovery Time	L = 200 A HI/H = 400 A / · · ·	-	10	-	ns
Qrr	Body Diode Reverse Recovery Charge	I _F = 20A, di/dt = 100A/us	-	1.7	-	nC

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- 2. E_{AS} condition: Starting T_J =25C, V_{DD} =15V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =18A
- 3. $R_{\theta JA}$ is measured with the device mounted on a 1inch $^{\!2}$ pad of 2oz copper FR4 PCB
- 4. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 0.5%.

Typical Performance Characteristics

Figure 1: Output Characteristics

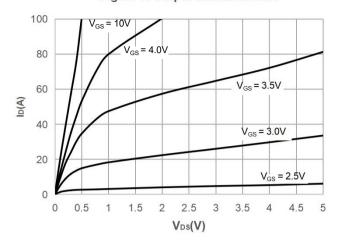


Figure 2: Typical Transfer Characteristics

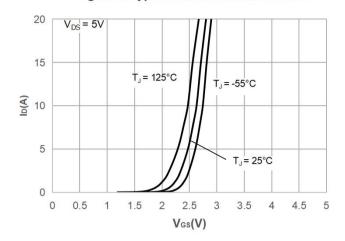


Figure 3: On-resistance vs. Drain Current

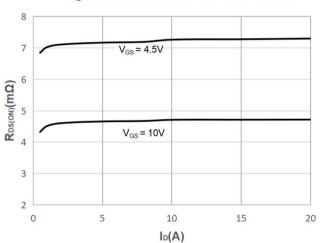


Figure 4: Body Diode Characteristics

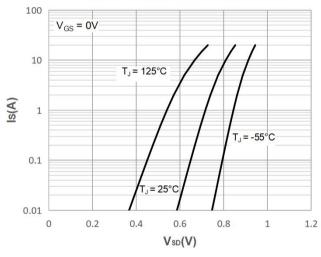


Figure 5: Gate Charge Characteristics

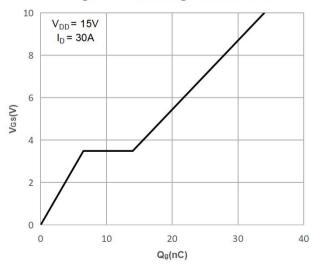
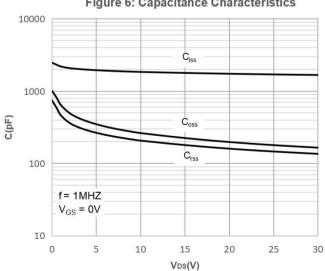


Figure 6: Capacitance Characteristics



Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs. **Junction Temperature**

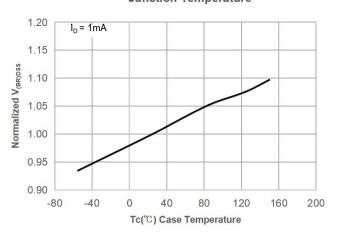


Figure 9: Maximum Safe Operating Area

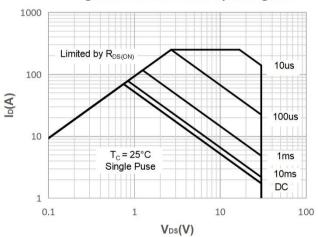


Figure 11: Normalized Maximum Transient Thermal Impedance

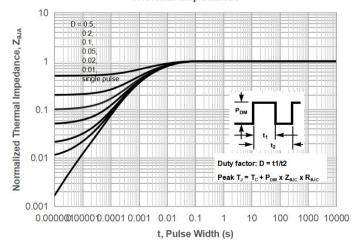


Figure 8: Normalized on Resistance vs. **Junction Temperature**

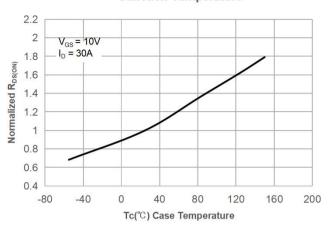


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

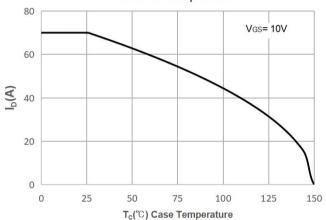
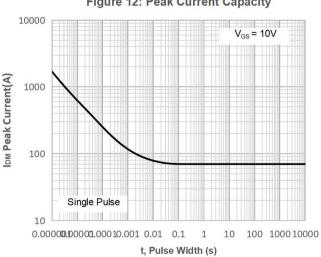


Figure 12: Peak Current Capacity





Test Circuit

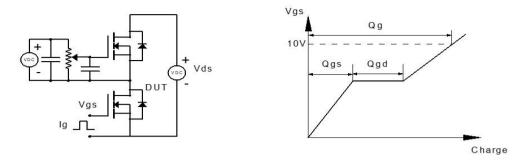


Figure 1: Gate Charge Test Circuit & Waveform

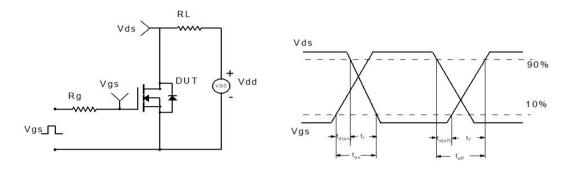


Figure 2: Resistive Switching Test Circuit & Waveform

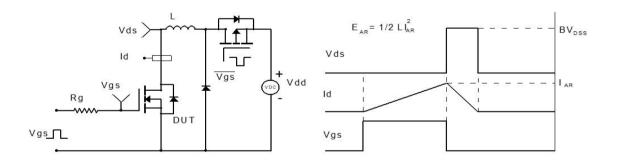


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

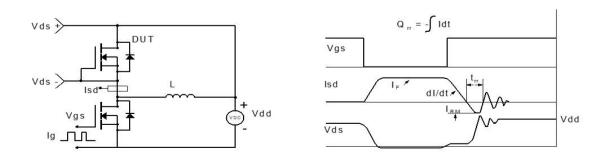
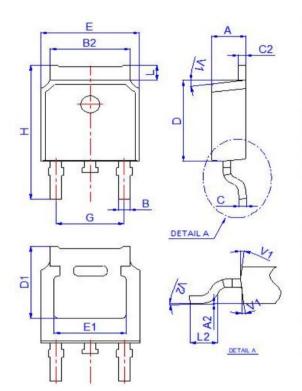


Figure 4: Diode Recovery Test Circuit & Waveform

Package Mechanical Data(TO-252-3L)



	Dimensions							
Ref.		Millimet	ers	Inches				
	Min.	Тур.	Max.	Min.	Тур.	Max.		
Α	2.10		2.50	0.083		0.098		
A2	0		0.10	0		0.004		
В	0.66		0.86	0.026		0.034		
B2	5.18		5.48	0.202		0.216		
С	0.40		0.60	0.016		0.024		
C2	0.44		0.58	0.017	-	0.023		
D	5.90		6.30	0.232		0.248		
D1	5.30REF			0.209REF				
E	6.40		6.80	0.252		0.268		
E1	4.63			0.182				
G	4.47		4.67	0.176		0.184		
Н	9.50		10.70	0.374		0.421		
L	1.09		1.21	0.043		0.048		
L2	1.35		1.65	0.053		0.065		
V1		7°			7°			
V2	0°		6°	0°	6.	6°		

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